


<b>Search Notes</b>  	<b>Application/Control No.</b>  10084258	<b>Applicant(s)/Patent Under Reexamination</b>  HEGDE ET AL.
	<b>Examiner</b>  Stork, Kyle R	<b>Art Unit</b>  2178

SEARCHED			
Class	Subclass	Date	Examiner
715	513, 517, 523, 530	6/28/07	
715	234, 243, 254, 255	5/14/08	
715	234, 243, 254, 255	10/28/08	
715	234, 243, 254, 255	3/28/09	

SEARCH NOTES			
Search Notes		Date	Examiner
Update EAST Search (USPat, USPG-Pub)		6/28/07	
NPL Search (IEEE, ACM, Google)		6/27/08	
Update EAST Search (USPat, USPG-Pub)		5/14/08	
NPL Search (IEEE, ACM, Google)		5/14/08	
Update EAST Search (USPat, USPG-Pub)		10/28/08	
Update NPL Search (IEEE, ACM, Google, Safari)		10/28/08	
Update EAST Search (USPat, USPG-Pub)		3/28/09	
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INTERFERENCE SEARCH			
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